Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,199	GROS ET AL.
Examiner	Art Unit
Gopal C. Ray	2111

SEARCHED				
Class	Subclass	Date	Examiner	
710	305,105,1 5	6/23/2005	GCR	
709	224,217	6/23/2005	GCR	
709	249	6/23/2005	GCR	
370	245,252	6/23/2005	GCR	
370	451	6/23/2005	GCR	
713	153,154	6/23/2005	GCR	
702	122,190	6/24/2005	GCR	
714	47,799	6/24/2005	GCR	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
* p = 100					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB	6/23/2005	GCR		
EAST: USPT	6/23/2005	GCR		
NPL: IEEE Xplore	6/23/2005	GCR		
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